

Search Notes

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Thien D. Tran

Applicant(s)/Patent under
Reexamination

KRONESTEDT ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
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**SEARCH NOTES
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	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT). See search printout	12/1/2006	TT